## (19) World Intellectual Property Organization International Bureau





(43) International Publication Date 16 December 2004 (16.12.2004)

PCT

## (10) International Publication Number WO 2004/109527 A1

(51) International Patent Classification7: G01R 31/28

G06F 13/00,

(21) International Application Number:

PCT/US2004/017461

(22) International Filing Date:

3 June 2004 (03.06.2004)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data: 2003-158091

3 June 2003 (03.06.2003) ЛР

- (71) Applicant (for all designated States except US): AGI-LENT TECHNOLOGIES, INC. [US/US]; 395 Page Mill Road, P.O. Box 10395, Palo Alto, CA 94303-0870 (US).
- (72) Inventor; and
- (75) Inventor/Applicant (for US only): HARADA, Koji [JP/JP]; 32-12, Tainohata-Minami, Suma-Ku, Kobe-Shi, Hyogo 654-0132 (JP).
- (74) Agent: GREELEY, Paul, D.; Ohlandt, Greeley, Ruggiero & Perle, L.L.P., One Landmark Square, 10th Floor, Stamford, CT 06901-2682 (US).

- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LS, MW, MZ, NA, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PL, PT, RO, SE, SI, SK, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

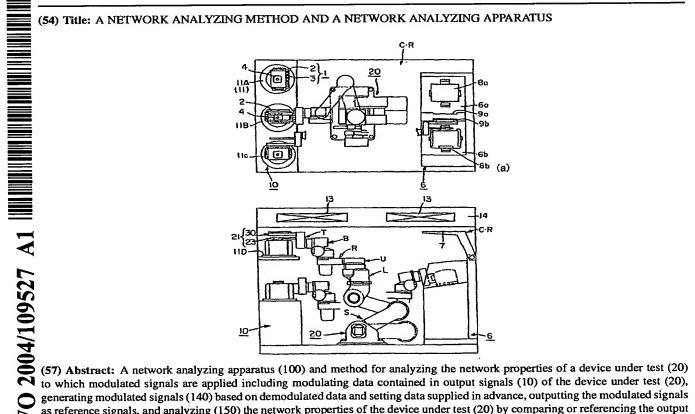
#### Published:

- with international search report
- with amended claims

17 March 2005 Date of publication of the amended claims:

[Continued on next page]

# (54) Title: A NETWORK ANALYZING METHOD AND A NETWORK ANALYZING APPARATUS



generating modulated signals (140) based on demodulated data and setting data supplied in advance, outputting the modulated signals as reference signals, and analyzing (150) the network properties of the device under test (20) by comparing or referencing the output signals of the device under test and these reference signals.

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

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### AMENDED CLAIMS

[received by the International Bureau on 14 December 2004 (14.12.04); original claims 1 and 8 amended, remaining claims unchanged (3 pages)]

- 1. A network analyzing device which analyzes network properties of a device under test to which modulated signals are applied, said device comprising:
  - a demodulator which demodulates data contained in output signals from said device under test;

a reference-signal generator which generates said modulated signals based on data that has been demodulated by said demodulator and outputs said modulated signals as reference signals; and

an analyzer which analyzes said network properties of said device under test by comparing or referencing the output signals of said device under test and said reference signals.

- 2. The apparatus according to claim 1, wherein said analyzer analyzes the frequency properties of said device under test by: modeling said device under test with a filter; fixing the pulse response of said filter from said output signals of said device under test and said reference signals; and performing a Fourier transform of said pulse response.
- 3. The apparatus according to claim 1, wherein said analyzer analyzes the electrical power properties of said device under test by: detecting the amplitude ratio of said output signals of said device under test and said reference signals; and analyzing the correlation between the amplitude of said output signals of said device under test and said amplitude ratio.
- 4. The apparatus according to claim 1, wherein said analyzer analyzes the electrical power properties of said device under test by: detecting the phase difference between said output signals of said device under test and said reference signals; and analyzing the correlation between the amplitude of said output signals of said device under test and said phase difference.
- 5. The apparatus according to claim 1, wherein said analyzer analyzes the amplitude noise properties of said device under test by: detecting the amplitude difference

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between said output signals of said device under test and said reference signals; and performing a Fourier transform of said amplitude difference.

- 6. The apparatus according to claim 1, wherein said analyzer analyzes the phase noise properties of said device under test by detecting the phase difference between said output signals of said device under test and said reference signals; and performing a Fourier transform of said phase difference.
- 7. The apparatus according to claim 1, wherein said modulated signals are digital modulated signals, and said data is digital data.
- 8. A network analyzing method for analyzing network properties of a device under test to which modulated signals are applied, said method comprising:

modulating data contained in output signals of said device under test to produce demodulated data;

generating modulated signals based on said demodulated data;
outputting said modulated signals as reference signals; and
analyzing said network properties of said device under test by comparing or
referencing said output signals of said device under test and said
reference signals.

- 9. The method according to claim 8, wherein said network properties analyzed are the frequency properties of said device under test and wherein said analyzing comprises: modeling said device under test with a filter; fixing the pulse response of said filter from the output signals of said device under test and said reference signals; and performing a Fourier transform of said pulse response.
- 10. The method according to claim 8, wherein said network properties analyzed are the electrical properties of said device under test and wherein said analyzing comprises: detecting the amplitude ratio of said output signals of said device under test and said reference signals; and analyzing the correlation between the amplitude of said output signals of said device under test and said amplitude ratio.

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11. The method according to claim 8, wherein said network properties analyzed are the electrical properties of said device under test and wherein said analyzing comprises: detecting the phase difference between said output signals of said device under test and said reference signals; and analyzing the correlation between the amplitude of the output signals of said device under test and said phase difference.

- 12. The method according to claim 8, wherein said network properties analyzed are the amplitude noise properties of said device under test and wherein said analyzing comprises: detecting the amplitude difference between said output signals of said device under test and said reference signals; and performing a Fourier transform of said amplitude difference.
- 13. The method according to claim 8, wherein said network properties analyzed are the phase noise properties of said device under test and wherein said analyzing comprises: detecting the phase difference between said output signals of said device under test and said reference signals; and performing a Fourier transform of said phase difference.
- 14. The method according to claim 8, wherein said modulated signals are digital modulated signals, and said data are digital data.